

N-Channel 100-V (D-S) MOSFET

Description

The device is using trench DMOS technology. This advanced technology has been especially tailored to minimize $R_{DS(ON)}$, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

The device meets the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Features

- R_{DS(ON)} = 4.2mΩ@ V_{GS} = 10V
- Fast switching
- Improve dv/dt Capability
- 100% EAS Guaranteed
- Green Device Available

Typical Applications

- Networking
- Load Switch
- Synchronous Rectifier
- Quick Charger

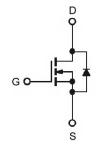
Package type : TO-263

Packing & Order Information 800/Reel

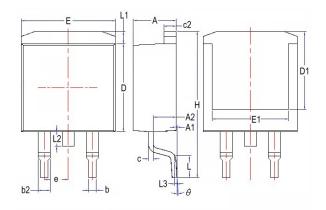


RoHS Compliant

Graphic Symbol

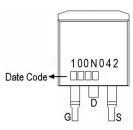


Package Dimension



REF.	Millimeter		REF.	Millimeter		
	Min.	Max.	REF.	Min.	Max.	
Α	4.37	4.77	E	9.80	10.36	
A1	0.00	0.25	E1	7.06	-	
A2	2.20	2.80	е	2.54 BSC		
b	0.70	0.96	Н	14.70	15.70	
b2	1.17	1.47	L	2.00	2.60	
С	0.30	0.60	L1	1.07	1.47	
c2	1.22	1.42	L2	1.40	1.75	
D	8.50	9.30	L3	0.25 BSC		
D1	6.60	-	θ	0°	9°	

Marking





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MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings					
Symbol	Parameter	Value	Units		
VDS	Drain-Source Voltage	100	V		
V _{GS}	Gate-Source Voltage	+20/-12	V		
lp	Continuous Drain Current ¹ (T _c =25°C)	150	А		
U	Continuous Drain Current ¹ (T _c =100°C)	95	А		
I _{DM}	Pulsed Drain Current ^{1,2}	600	А		
las	Single Pulse Avalanche Current, L =0.1mH ³	87	А		
Eas	Single Pulse Avalanche Energy, L =0.1mH ³	378	mJ		
D	Power Dissipation ⁴ (T _C =25°C)	275	W		
PD	Power Dissipation ⁴ (T _A =25°C)	2	W		
TJ/Tstg	Operating Junction and Storage Temperature	-50 to +150	°C		

Thermal Resistance Ratings					
Symbol	Parameter	Maximum	Units		
R _{0JA}	Maximum Junction-to-Ambient ¹	62.5	°C/W		
R _{θJC}	Maximum Junction-to-Case ¹	0.45	°C/W		

Electrical Characteristics (T」=25°C unless otherwise specified)							
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units	
VGS (th)	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1.2	1.8	2.5	V	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250µA	100	-	-	V	
g fs	Forward Transconductance	V _{DS} =10V, I _D =3A	-	20	-	S	
lgss	Gate-Source Leakage Current	V _{DS} =0V, V _{GS} =20V	-	-	100	nA	
I _{DSS}	Drain-Source Leakage Current	V _{DS} =100V, V _{GS} =0V, T _J =25°C V _{DS} =80V, V _{GS} =0V, T _J =85°C	-	-	1 10	μA	
RDS (on)	Static Drain-Source On-Resistance ²	V _{GS} =10V, I _D =20A V _{GS} =4.5V, I _D =15A	-	3.5 5.0	4.2 6.0	mΩ	
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =25V, L =0.1mH, I _{AS} =40A	80	-	-	mJ	
V _{SD}	Diode Forward Voltage ²	Is =20A, V _{GS} =0V, T _J =25°C	-	-	1.2	V	
ls	Continuous Source Current ^{1,6}		-	-	150		
lsм	Pulsed Source Current ^{2,6}	$V_{G} = V_{D} = 0V$, Force Current	-	-	300	A	

Notes

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

2. The data tested by pulsed, pulse width \leq 300us, duty cycle \leq 2%.

3. The EAS data shows maximum rating. The test condition is V_{DD} =25V, V_{GS} =10V, L=0.1mH, I_{AS}=87A.

4. The power dissipation is limited by 150 $^\circ\!\mathrm{C}$ junction temperature.

5. The Min. value is 100% EAS tested guarantee.

6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



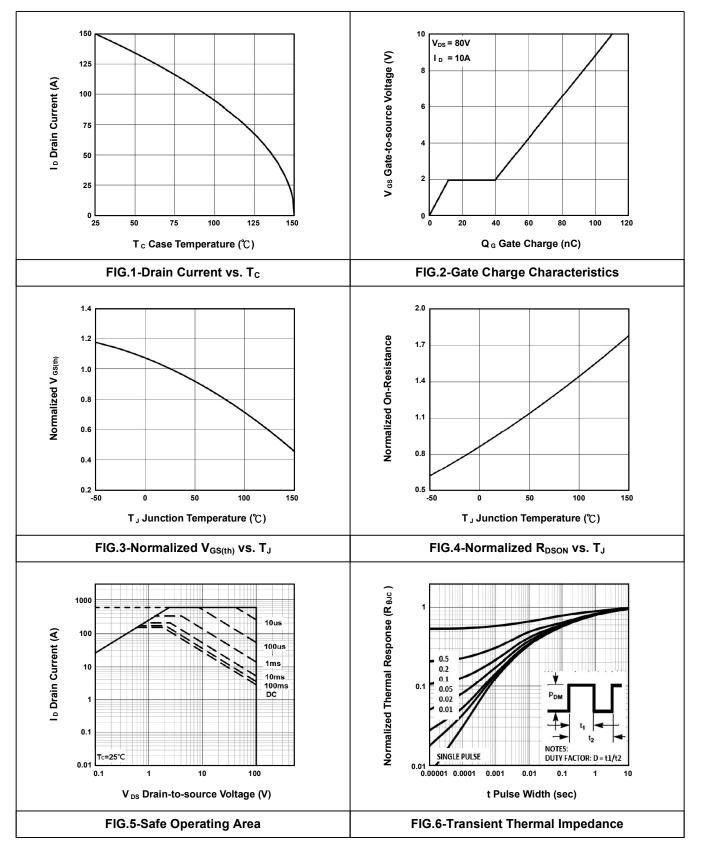
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Dynamic						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Qg	Total Gate Charge ²	V _{DS} =80V		110		
Qgs	Gate-Source Charge	I _D =10A		11.5		nC
Qgd	Gate-Drain Charge	V _{GS} =10V		28		
td(on)	Turn-On Delay Time ²	V _{DS} =50V		23		
tr	Rise Time	I _D =1A		32		
td(off)	Turn-Off Delay Time	V _{GS} =10V		157		ns
tf	Fall Time	$R_{G}=6\Omega$		115		-
Ciss	Input Capacitance	V _{DS} =25V		6680		
Coss	Output Capacitance	V _{GS} =0V		1690		pF
CRSS	Reverse Transfer Capacitance	f=1.0MHz		78]
Rg	Gate Resistance	V _{GS} =V _{DS} =0V, f =1.0MHz		1.9		Ω



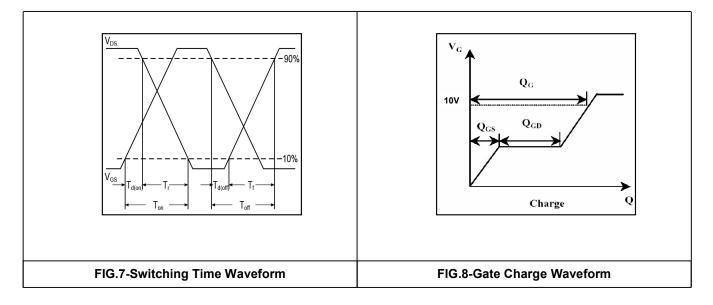
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• Typical Electrical Characteristics





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